| Search Notes | | | | |
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| Application No. | Applicant(s) | |
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| 09/885,853 | BERNIER ET AL. | |
| Examiner | Art Unit | |
| W David Coleman | 2823 | |

| SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
| 324 | 765 | 12/13/2004 | WDC |
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| SEARCH NOT (INCLUDING SEARCH | |) |
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| | DATE | EXMR |
| EAST 1.4.1 Applicant claims a conductive pad on a semiconductor die larger than the conductive pad on an organic substrate | 12/13/2004 | WDCD |
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